

# The 20th International Conference on RFID

# IEEE RFID 2026



Santa Fe, NM  
16-18 June, 2026  
[2026.ieee-rfid.org](https://2026.ieee-rfid.org)

## Call for Workshops

The **20th IEEE International Conference on RFID** (IEEE RFID 2026) invites high-quality workshop proposals on all aspects of RFID research and applications. The goal of workshops is to **engage the conference attendees with high-level talks, panel discussions, demos, or other forms of activities** that lead to meaningful engagement with the audience. Join us in Santa Fe, NM, June 16-18, 2026, to share and explore the latest in RFID technology at this special 20th-anniversary event.

### Workshops Overview

- Workshops highlight specific fields of RFID applications and research and lead to audience engagement.
- Accepted workshops will be scheduled in the conference program.
- Members of academia and industry, alike, are welcome to organize and lead their workshops.

### Submission Procedures

- All submissions need to include the following:
  - Workshop title
  - Short description (5-10 lines)
  - Covered topics
  - Workshop organizer(s) with affiliation(s)
  - List of potential speakers, panelists, demonstrators
- Please submit your workshop proposal at:  
<https://forms.gle/NUiqyHTY8KrBEVfx8>



### Potential Topics:

- RFID for high-consequence applications
- GS1 round table Q&A
- Energy harvesting
- Artificial intelligence for RFID
- Digital twins and cyber-physical radio systems
- New manufacturing techniques and prototyping
- Smart materials
- Flexible electronics
- Trends in RFID tag design
- Industrial session
- RFID 20th Anniversary Invited Talks

For questions, please contact  
[workshop@ieee-rfid.org](mailto:workshop@ieee-rfid.org)

To learn the latest on IEEE RFID 2026, visit <https://2026.ieee-rfid.org/>

Key Dates

- Workshops Proposal Deadline: **DEC 8, 2025**
- Notification of Workshop Acceptance: **DEC 15, 2025**

All deadlines are at 11:59pm UTC-12

### IEEE RFID 2026 Committee

**Executive Chair:** Brendon Parsons, Los Alamos National Laboratory (US)  
**Workshop Chair:** Christopher Saetia, Georgia Tech (US)  
[workshop@ieee-rfid.org](mailto:workshop@ieee-rfid.org)  
**TPC Co-Chairs:** Fatima Villa-Gonzalez, MIT (US)  
Michael Crisp, University of Cambridge (UK)  
[TPChair@ieee-rfid.org](mailto:TPChair@ieee-rfid.org)